

TUSB3210

***Universal Serial Bus
General-Purpose Device Controller***

Data Manual



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TUSB3210
Universal Serial Bus
General-Purpose Device Controller

SLLS466F—FEBRUARY 2001—REVISED AUGUST 2007

1 Introduction

1.1 Features

- **Multiproduct Support With One Code and One Chip (up to 16 Products With One Chip)**
 - Fully Compliant With USB 2.0 Full-Speed Specifications: TID #40270269
 - Supports 12 Mb/s USB Data Rate (Full Speed)
 - Supports USB Suspend/Resume and Remote Wake-up Operation
 - Integrated 8052 Microcontroller With:
 - 256 × 8 RAM for Internal Data
 - 8K × 8 RAM Code Space Available for Downloadable Firmware From Host or I²C Port. ⁽¹⁾
- 512 × 8 Shared RAM Used for Data Buffers and Endpoint Descriptor Blocks (EDB) ⁽²⁾
- Four 8052 GPIO Ports, Ports 0, 1, 2, and 3
 - Master I²C Controller for External Slave Device Access
 - Watchdog Timer
- Operates From a 12-MHz Crystal
- On-Chip PLL Generates 48 MHz
- Supports a Total of 3 Input and 3 Output (Interrupt, Bulk) Endpoints
- Powerdown Mode
- 64-Pin TQFP Package
- Applications Include Keyboard, Bar Code Reader, Flash Memory Reader, General-Purpose Controller

(1) The TUSB3210 has 8K × 8 RAM for development.

(2) This is the buffer space for USB packet transactions.

1.2 Description

The TUSB3210 is a USB-based controller targeted as a general-purpose MCU with GPIO. The TUSB3210 has 8K × 8 RAM space for application development. In addition, the programmability of the TUSB3210 makes it flexible enough to use for various other general USB I/O applications. Unique vendor identification and product identification (VID/PID) can be selected without the use of an external EEPROM. Using a 12-MHz crystal, the onboard oscillator generates the internal system clocks. The device can be programmed via an inter-IC (I²C) serial interface at power on from an EEPROM, or optionally, the application firmware can be downloaded from a host PC via USB. The popular 8052-based microprocessor allows several third-party standard tools to be used for application development. In addition, the vast amounts of application code available in the general market also can be used (this may or may not require some code modification due to hardware variations).

1.3 Ordering Information

| PRODUCT | PACKAGE ⁽¹⁾⁽²⁾ | PACKAGE CODE | OPERATING TEMPERATURE RANGE | PACKAGE MARKING | ORDERING NUMBER | TRANSPORT MEDIA |
|------------|---------------------------|--------------|-----------------------------|-----------------|-----------------|-----------------|
| TUSB3210PM | Plastic quad flatpack 64 | PM | 0°C to 70°C | TUSB3210PM | TUSB3210PM | 160-piece tray |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



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1.4 Device Information

Functional Block Diagram

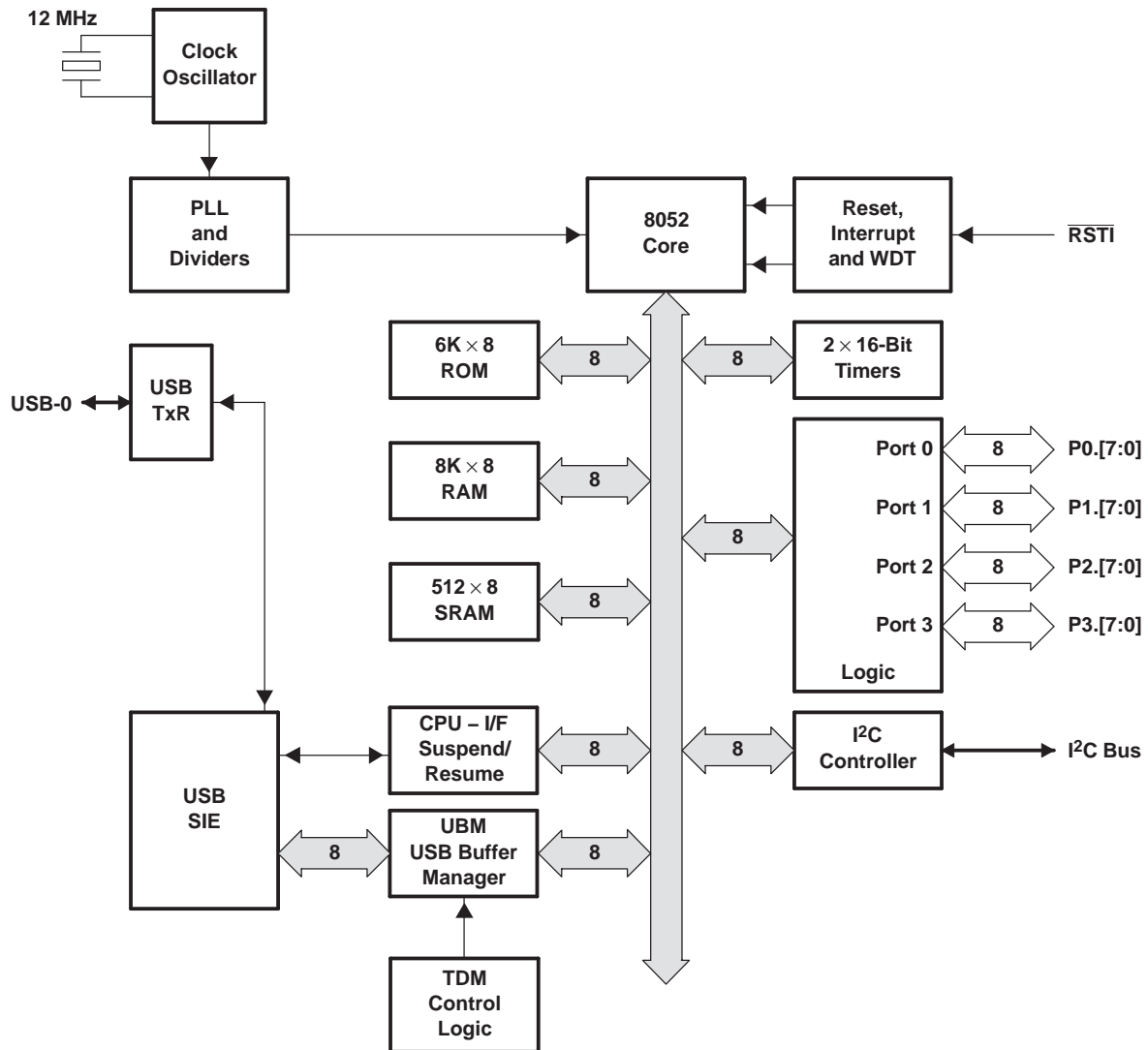


Figure 1-1. TUSB3210 Block Diagram

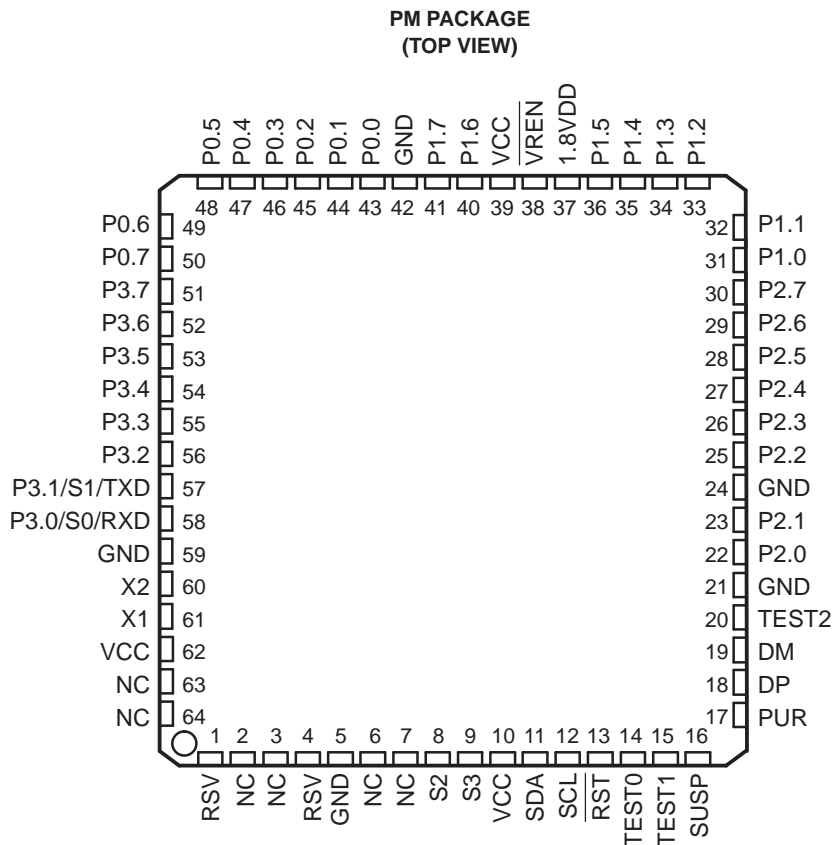


Figure 1-2. Terminal Assignments

Table 1-1. Terminal Functions

| TERMINAL NAME | NO. | I/O | DESCRIPTION |
|-----------------------|--------------------------------|-----|--|
| 1.8VDD ⁽¹⁾ | 37 | I/O | 1.8 V. When \overline{VREN} is high, 1.8 V must be applied externally to provide current for the core during suspend. |
| DM | 19 | I/O | Differential data-minus USB |
| DP | 18 | I/O | Differential data-plus USB |
| GND | 5, 21 24, 42, 59 | — | Power supply ground |
| NC | 2, 3, 6, 7, 63, 64 | | No connection |
| P0.[0:7] | 43, 44, 45, 46, 47, 48, 49, 50 | I/O | General-purpose I/O port 0 bits 0–7, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |
| P1.[0:7] | 31, 32, 33, 34, 35, 36, 40, 41 | I/O | General-purpose I/O port 1 bits 0–7, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |

- (1) During normal operation, the internal 3.3- to 1.8-V voltage regulator of the TUSB3210 is enabled and provides power to the core. To save power during the suspend mode, the internal regulator is disabled. In this case, the pin becomes an input, and a simple external power source is required to provide power to the core. This source needs to supply a limited amount of power (10 μ A maximum) within the voltage range of 1 to 1.95 V.
- (2) All open-drain output pins can sink up to 8 mA.

Table 1-1. Terminal Functions (continued)

| TERMINAL NAME | NO. | I/O | DESCRIPTION |
|--------------------------|--------------------------------|-----|--|
| P2.[0:7] | 22, 23, 25, 26, 27, 28, 29, 30 | I/O | General-purpose I/O port 2 bits 0–7, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |
| P3.0/S0/RXD | 58 | I/O | P3.0: General-purpose I/O port 3 bit 0, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |
| | | | S0: See Section 2.6.5 . RXD: Can be used as a UART interface |
| P3.1/S1/TXD | 57 | I/O | P3.1: General-purpose I/O port 3 bit 1, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |
| | | | S1: See Section 2.6.5 . TXD: Can be used as a UART interface |
| P3.2 | 56 | I/O | General-purpose I/O port 3 bit 2, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ ; $\overline{\text{INT0}}$ only used internally (see Section 2.9.4) |
| P3.3 | 55 | I/O | General-purpose I/O port 3 bit 3, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ ; may support $\overline{\text{INT1}}$ input, depending on configuration (see Figure 2-5) |
| P3.[4:7] | 54, 53, 52, 51 | I/O | General-purpose I/O port 3 bits 4–7, Schmitt-trigger input, 100- μ A active pullup, open-drain output ⁽²⁾ |
| PUR | 17 | O | Pullup resistor connection pin (3-state) push-pull CMOS output (± 4 mA) |
| $\overline{\text{RST}}$ | 13 | I | Controller master reset signal, Schmitt-trigger input, 100- μ A active pullup |
| RSV | 1, 4 | | Reserved (Do not connect these pins.) |
| S2 | 8 | I | General-purpose input, can be used for VID/PID selection under firmware control. This input has no internal pullup; therefore, it must be driven/pulled either low or high and cannot be left unconnected. |
| S3 | 9 | I | General-purpose input. This input has no internal pullup; therefore, it must be driven/pulled either low or high and cannot be left unconnected. |
| SCL | 12 | O | Serial clock I ² C; push-pull output |
| SDA | 11 | I/O | Serial data I ² C; open-drain output ⁽²⁾ |
| SUSP | 16 | O | Suspend status signal: suspended (HIGH); unsuspended (LOW) |
| TEST0 ⁽³⁾ | 14 | I | Test input0, Schmitt-trigger input, 100- μ A active pullup |
| TEST1 ⁽³⁾ | 15 | I | Test input1, Schmitt-trigger input, 100- μ A active pullup |
| TEST2 | 20 | I | Test input2, Schmitt-trigger input, 100- μ A active pullup. This pin is reserved for testing purposes and should be left unconnected. |
| VCC | 10, 39, 62 | — | Power supply input, 3.3 V typical |
| $\overline{\text{VREN}}$ | 38 | I | Voltage regulator enable: enable active-LOW; disable active-HIGH |
| X1 | 61 | I | 12-MHz crystal input |
| X2 | 60 | O | 12-MHz crystal output |

(3) The functions controlled by TEST0 and TEST1 are shown in [Table 1-2](#). Because these pins have internal pullups, they can be left unconnected for the default mode.

Table 1-2. Test0/Test1 Functions

| TEST0 | TEST1 | Function |
|-------|-------|---|
| 0 | 0 | Selects 48-MHz clock input (from an oscillator or other onboard clock source) |
| 0 | 1 | Reserved for testing purposes |
| 1 | 0 | Reserved for testing purposes |
| 1 | 1 | Selects 12-MHz crystal as clock source (default) |

1.5 Revision History

| Revision | Date | Changes |
|----------|---------------|---|
| | February 2001 | Initial release |
| A | February 2003 | <ol style="list-style-type: none"> 1. Removed most references to ROM version, including the <i>MCU Memory Map (ROM Version)</i> figure. 2. Clarified pin names and descriptions for pins 8 (S2), 9 (S3), 21 (GND), 37 (VDD18), 57 (P3.1/S1/TXD), and 58 (P3.0/S0/RXD). 3. Removed NOTE from cover page. 4. Expanded <i>Ordering Information</i> table. 5. Clarified pin functions for pins 14 (TEST0) and 15 (TEST1) (14 & 15) in <i>Terminal Functions</i> table. Simplified <i>Terminal Function</i> table for GPIO ports. 7. Added note on open-drain output pins for <i>Terminal Functions</i> table. 8. Added ET2 information to the <i>8052 Interrupt Location Map</i> table and further clarified the entire <i>8052 Interrupt and Status Registers</i> section. 9. Corrected quiescent and suspend current values in <i>Electrical Characteristics</i> table. |
| B | April 2003 | <ol style="list-style-type: none"> 1. Grammatical clean-up 2. Clarification on pin 55 (P3.3) and its functionality as $\overline{INT1}$. 3. Additional corrections in the <i>8052 Interrupt and Status Registers</i> section. |
| C | Nov-2003 | <ol style="list-style-type: none"> 1. Added USB logo to cover page. 2. Corrected pin 37 (1.8VDD) polarity in <i>Terminal Functions</i> table. 3. Removed note for pin 20 (TEST2) from <i>Terminal Functions</i> table. 4. Removed application diagram Figure 4-4. 5. Clarified Section 4-2, Reset Timing |
| D | June 2004 | <ol style="list-style-type: none"> 1. Corrected description for pin 20 (TEST2). 2. Added description of programmable delay to the <i>P2[7:0], P3.3 Interrupt ($\overline{INT1}$)</i> section. 3. Added delay values for I[3:0] to the INTCFG register description. |
| E | August 2007 | <ol style="list-style-type: none"> 1. Deleted reference to 8K × 8 ROM 2. Clarified Section 2.2.2, bit 0. 3. Clarified Section 2.6.5 (VID/PID support) |

2 Functional Description

2.1 MCU Memory Map

Figure 2-1 illustrates the MCU memory map under boot and normal operation. It must be noted that the internal 256 bytes of IDATA are not shown because it is assumed to be in the standard 8052 location (0000 to 00FF). The shaded areas represent the internal ROM/RAM.

When the SDW bit = 0 (boot mode): The 6K ROM is mapped to address 0000–17FF and is duplicated in location 8000–97FF in code space. The internal 8K RAM is mapped to address range 0000–1FFF in data space. Buffers, MMR and I/O are mapped to address range (FD80–FFFF) in data space.

When the SDW bit = 1 (normal mode): The 6K ROM is mapped to 8000–97FF in code space. The internal 8K RAM is mapped to address range 0000–1FFF in code space. Buffers, MMR, and I/O are mapped to address range FD80–FFFF in data space.

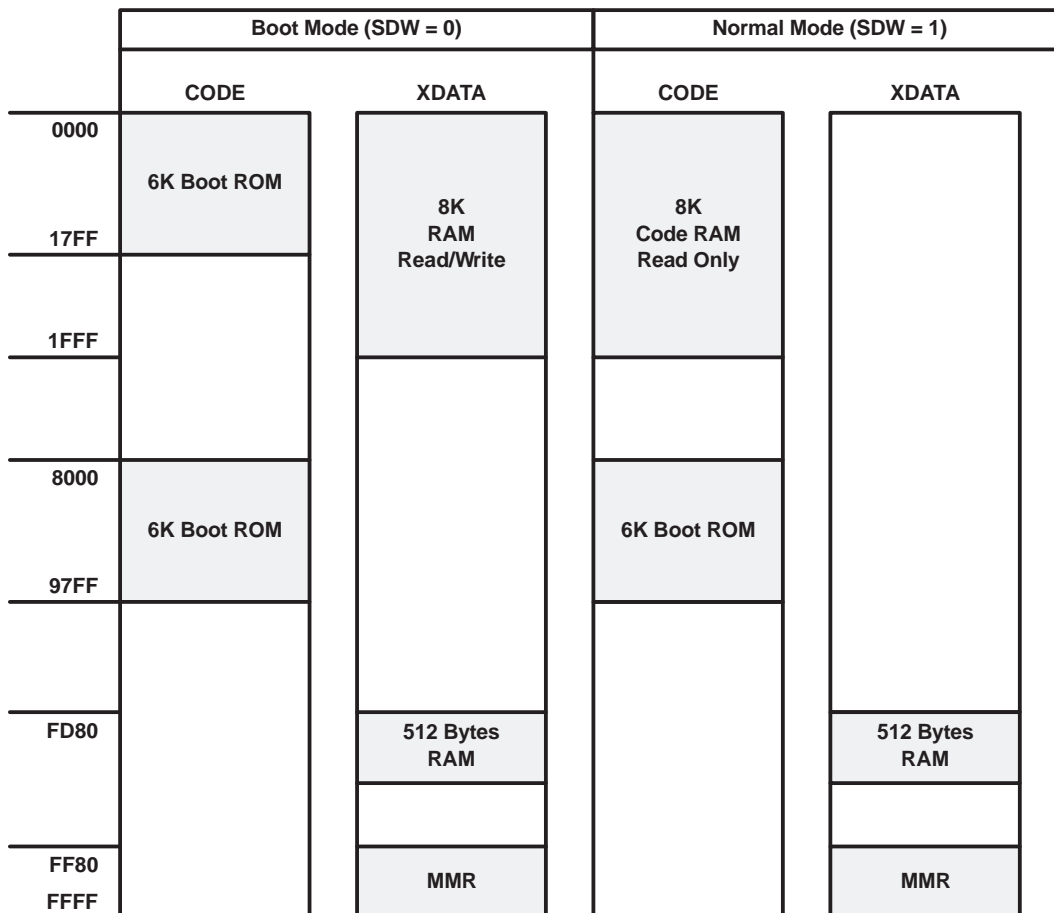


Figure 2-1. MCU Memory Map (TUSB3210)

2.2 Miscellaneous Registers

2.2.1 TUSB3210 Boot Operation

Because the code space is in RAM (with the exception of the boot ROM), the TUSB3210 firmware must be loaded from an external source. Two options for booting are available: an external serial EEPROM source can be connected to the I²C bus, or the host can be used via the USB. On device reset, the SDW bit (in the ROM register) and the CONT bit in the USB control register (USBCTL) are cleared. This configures the memory space to boot mode (see memory map, [Table 2-2](#)) and keeps the device *disconnected* from the host.

The first instruction is fetched from location 0000 (which is in the 6K ROM). The 8K RAM is mapped to XDATA space (location 0000h). The MCU executes a read from an external EEPROM and tests to determine if it contains the code (test for boot signature). If it contains the code, the MCU reads from EEPROM and writes to the 8K RAM in XDATA space. If not, the MCU proceeds to boot from the USB.

Once the code is loaded, the MCU sets SDW to 1. This switches the memory map to normal mode; i.e., the 8K RAM is mapped to code space, and the MCU starts executing from location 0000h. Once the switch is done, the MCU sets CONT to 1 (in USBCTL register) This *connects* the device to the USB bus, resulting in the normal USB device enumeration.

2.2.2 MCNFG: MCU Configuration Register

This register is used to control the MCU clock rate. (R/O notation indicates read only by the MCU.)

| | | | | | | | |
|-----|------|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RSV | XINT | RSV | R3 | R2 | R1 | R0 | SDW |
| R/W | R/W | R/O | R/O | R/O | R/O | R/O | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-----------|--|
| 0 | SDW | 0 | This bit enables/disables boot ROM. |
| | | | SDW = 0 When clear, the MCU executes from the 6K boot ROM space. The boot ROM appears in two locations: 0000 and 8000h. The 8K RAM is mapped to XDATA space; therefore, read/write operation is possible. This bit is set by the MCU after the RAM load is completed. The MCU cannot clear this bit. It is cleared on power-up reset or function reset. |
| | | | SDW = 1 When set by the MCU, the 6K boot ROM maps to location 8000h, and the 8K RAM is mapped to code space, starting at location 0000h. At this point, the MCU executes from RAM, and write operation is disabled (no write operation is possible in code space). |
| 4–1 | R[3:0] | No effect | These bits reflect the device revision number. |
| 5 | RSV | 0 | Reserved |
| 6 | XINT | 0 | INT1 source control bit |
| | | | XINT = 0 INT1 is connected to the P3.3 pin and operates as a standard INT1 interrupt. |
| | | | XINT = 1 INT1 is connected to the OR of the port-2 inputs. |
| 7 | RSV | 0 | Reserved |

2.2.3 PUR_n: GPIO Pullup Register for Port n (n = 0 to 3)

PUR₀: GPIO pullup register for port 0

PUR₁: GPIO pullup register for port 1

PUR₂: GPIO pullup register for port 2

PUR₃: GPIO pullup register for port 3

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------------------|---------------------|---------------------|---------------------|---------------------|---------------------|---------------------|---------------------|
| PORT _{n.7} | PORT _{n.6} | PORT _{n.5} | PORT _{n.4} | PORT _{n.3} | PORT _{n.2} | PORT _{n.1} | PORT _{n.0} |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|-------------------------------------|-------|---|
| 0–7 | PORT _{n.N} (N = 0 to 7) | 0 | The MCU can write to this register. If the MCU sets this bit to 1, the internal pullup resistor is disconnected from the pin. If the MCU clears this bit to 0, the pullup resistor is connected to the pin. The pullup resistor is connected to the V _{CC} power supply. |

2.2.4 INTCFG: Interrupt Configuration

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----|-----|-----|-----|-----|-----|-----|-----|
| RSV | RSV | RSV | RSV | I3 | I2 | I1 | I0 |
| R/O | R/O | R/O | R/O | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|--------|----------------|-------|--|--------|-------|------|------|------|------|------|----------------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|-------|------|------|------|------|------|------|------|------|------|------|
| 0–3 | I[3:0] | 0010 | <p>The MCU can write to this register to set the interrupt delay time for port 2 on the MCU. The value of the lower nibble represents the delay in ms. Default after reset is 2 ms.</p> <table border="1"> <thead> <tr> <th>I[3:0]</th> <th>Delay</th> </tr> </thead> <tbody> <tr><td>0000</td><td>5 ms</td></tr> <tr><td>0001</td><td>5 ms</td></tr> <tr><td>0010</td><td>2 ms (default)</td></tr> <tr><td>0011</td><td>3 ms</td></tr> <tr><td>0100</td><td>4 ms</td></tr> <tr><td>0101</td><td>5 ms</td></tr> <tr><td>0110</td><td>6 ms</td></tr> <tr><td>0111</td><td>7 ms</td></tr> <tr><td>1000</td><td>8 ms</td></tr> <tr><td>1001</td><td>9 ms</td></tr> <tr><td>1010</td><td>10 ms</td></tr> <tr><td>1011</td><td>5 ms</td></tr> <tr><td>1100</td><td>5 ms</td></tr> <tr><td>1101</td><td>5 ms</td></tr> <tr><td>1110</td><td>5 ms</td></tr> <tr><td>1111</td><td>5 ms</td></tr> </tbody> </table> | I[3:0] | Delay | 0000 | 5 ms | 0001 | 5 ms | 0010 | 2 ms (default) | 0011 | 3 ms | 0100 | 4 ms | 0101 | 5 ms | 0110 | 6 ms | 0111 | 7 ms | 1000 | 8 ms | 1001 | 9 ms | 1010 | 10 ms | 1011 | 5 ms | 1100 | 5 ms | 1101 | 5 ms | 1110 | 5 ms | 1111 | 5 ms |
| I[3:0] | Delay | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0000 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0001 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0010 | 2 ms (default) | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0011 | 3 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0100 | 4 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0101 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0110 | 6 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 0111 | 7 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1000 | 8 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1001 | 9 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1010 | 10 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1011 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1100 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1101 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1110 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 1111 | 5 ms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| 4–7 | RSV | 0 | Reserved | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |

2.2.5 WDCSR: Watchdog Timer, Control, and Status Register

A watchdog timer (WDT) with 1-ms clock is provided. The watchdog timer works only when a USB start-of-frame has been detected by the TUSB3210. If this register is not accessed for a period of 32 ms, the WDT counter resets the MCU (see [Figure 2-2](#), Reset Diagram). When the IDL bit in PCON is set, the WDT is suspended until an interrupt is detected. At this point, the IDL bit is cleared and the WDT resumes operation. The WDE bit of this register is cleared only on power up or USB reset (if enabled). When the MCU writes a 1 to the WDE bit of this register, the WDT starts running. (W/O notation indicates write only by the MCU.)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| WDE | WDR | RSV | RSV | RSV | RSV | RSV | WDT |
| R/W | R/W | R/O | R/O | R/O | R/O | R/O | W/O |

| BIT | NAME | RESET | FUNCTION | |
|---------|---|-------|---|----------|
| 0 | WDT | 0 | The MCU must write a 1 to this bit to prevent the WDT from resetting the MCU. If the MCU does not write a 1 in a period of 31 ms, the WDT resets the device. Writing a 0 has no effect on the WDT. (WDT is a 5-bit counter using a 1-ms CLK.) This bit is read as 0. | |
| 5–1 | RSV | 0 | Reserved = 0 | |
| 6 | WDR | 0 | Watchdog reset indication bit. This bit indicates if the reset occurred due to power-on reset or watchdog timer reset. | |
| | | | <table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 20%;">WDR = 0</td> <td>A power-up or USB reset occurred.</td> </tr> <tr> <td>WDR = 1</td> <td>A watchdog time-out reset occurred. To clear this bit, the MCU must write a 1. Writing a 0 has no effect.</td> </tr> </table> | WDR = 0 |
| WDR = 0 | A power-up or USB reset occurred. | | | |
| WDR = 1 | A watchdog time-out reset occurred. To clear this bit, the MCU must write a 1. Writing a 0 has no effect. | | | |
| 7 | WDE | 0 | Watchdog timer enable. | |
| | | | WDE = 0 | Disabled |
| | | | WDE = 1 | Enabled |

2.2.6 PCON: Power Control Register (at SFR 87h)

| | | | | | | | |
|------|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| SMOD | RSV | RSV | RSV | GF1 | GF0 | RSV | IDL |
| R/W | R/O | R/O | R/O | R/W | R/W | R/O | R/W |

| BIT | NAME | RESET | FUNCTION | |
|-----|---------|-------|--|--|
| 0 | IDL | 0 | MCU idle mode bit. This bit can be set by the MCU and is cleared only by the $\overline{INT1}$ interrupt. | |
| | | | IDL = 0 | The MCU is not in idle mode. This bit is cleared by the $\overline{INT1}$ interrupt logic when $\overline{INT1}$ is asserted for at least 400 μ s. |
| | | | IDL = 1 | The MCU is in idle mode and RAM is in low-power mode. The oscillator/APLL is off and the WDT is suspended. When in suspend mode, only $\overline{INT1}$ can be used to exit from idle state and generate an interrupt. $\overline{INT1}$ must be asserted for at least 400 μ s for the interrupt to be recognized. |
| 1 | RSV | 0 | Reserved | |
| 3–2 | GF[1:0] | 00 | General-purpose bits. The MCU can write and read them. | |
| 6–4 | RSV | 0 | Reserved | |
| 7 | SMOD | 0 | Double baud-rate control bit. For more information, see the UART serial interface in the M8052 core specification. | |

2.3 Buffers + I/O RAM Map

The address range from FD80 to FFFF is reserved for data buffers, setup packet, endpoint descriptor blocks (EDB), and all I/O. RAM space of 512 bytes [FD80–FF7F] is used for EDB and buffers. The FF80–FFFF range is used for memory-mapped registers (MMR). [Table 2-1](#) represents the internal XDATA space allocation.

Table 2-1. XDATA Space

| DESCRIPTION | ADDRESS RANGE | |
|--|---------------|--------------|
| Internal memory-mapped registers (MMR) | FFFF | 512-Byte RAM |
| | ↑ | |
| Endpoint descriptor blocks (EDB) | FF80 | |
| | FF7F | |
| Setup packet buffer | ↑ | |
| | FF08 | |
| Input endpoint-0 buffer | FF07 | |
| | ↑ | |
| Output endpoint-0 buffer | FF00 | |
| | FEFF | |
| Data buffers (368 bytes) | ↑ | |
| | FEF8 | |
| | FEF7 | |
| | ↑ | |
| | FEF0 | |
| | FEEF | |
| | ↑ | |
| | FD80 | |

Table 2-2. Memory-Mapped Register Summary (XDATA Range = FF80 → FFFF)

| ADDRESS | REGISTER | DESCRIPTION |
|---------|-----------|--|
| FFFF | FUNADR | FUNADR: Function address register |
| FFFE | USBSTA | USBSTA: USB status register |
| FFFD | USBMSK | USBMSK: USB interrupt mask register |
| FFFC | USBCTL | USBCTL: USB control register |
| ↑ | RESERVED | |
| FFF6 | VIDSTA | VIDSTA: VID/PID status register |
| ↑ | RESERVED | |
| FFF3 | I2CADR | I2CADR: I ² C address register |
| FFF2 | I2CDAI | I2CDAI: I ² C data-input register |
| FFF1 | I2CDAO | I2CDAO: I ² C data-output register |
| FFF0 | I2CSTA | I2CSTA: I ² C status and control register |
| ↑ | RESERVED | |
| FF97 | PUR3 | Port 3 pullup resistor register |
| FF96 | PUR2 | Port 2 pullup resistor register |
| FF95 | PUR1 | Port 1 pullup resistor register |
| FF94 | PUR0 | Port 0 pullup resistor register |
| FF93 | WDCSR | WDCSR: Watchdog timer, control and status register |
| FF92 | VECINT | VECINT: Vector interrupt register |
| FF91 | RESERVED | |
| FF90 | MCNFG | MCNFG: MCU configuration register |
| ↑ | RESERVED | |
| FF84 | INTCFG | INTCFG: Interrupt delay configuration register |
| FF83 | OEPBCNT_0 | OEPBCNT_0: Output endpoint-0 byte count register |
| FF82 | OEPCNFG_0 | OEPCNFG_0: Output endpoint-0 configuration register |
| FF81 | IEPBCNT_0 | IEPBCNT_0: Input endpoint-0 byte count register |
| FF80 | IEPCNFG_0 | IEPCNFG_0: Input endpoint-0 configuration register |

2.4 Endpoint Descriptor Block (EDB-1 to EDB-3)

Data transfers between USB, MCU and external devices are defined by an endpoint descriptor block (EDB). Four input and four output EDBs are provided. With the exception of EDB-0 (I/O endpoint 0), all EDBs are located in SRAM as shown in [Table 2-3](#). Each EDB contains information describing the X and Y buffers. In addition, it provides general status information.

Table 2-3. EDB and Buffer Allocations in XDATA

| ADDRESS | SIZE | DESCRIPTION |
|-------------------|-----------|--|
| FF7F ↑ FF60 | 32 bytes | RESERVED |
| FF5F ↑ FF58 | 8 bytes | Input endpoint 3: configuration |
| FF57 ↑ FF50 | 8 bytes | Input endpoint 2: configuration |
| FF4F ↑ FF48 | 8 bytes | Input endpoint 1: configuration |
| FF47 ↑ FF20 | 40 bytes | RESERVED |
| FF1F ↑ FF18 | 8 bytes | Output endpoint 3: configuration |
| FF17 ↑ FF10 | 8 bytes | Output endpoint 2: configuration |
| FF0F ↑ FF08 | 8 bytes | Output endpoint 1: configuration |
| FF07 ↑ FF00 | 8 bytes | Setup packet block |
| FEFF ↑ FEF8 | 8 bytes | Input endpoint 0: buffer |
| FEF7 ↑ FEF0 | 8 bytes | Output endpoint 0: buffer |
| FEFF ↑ FD80 | 368 bytes | Top of buffer space Buffer space Start of buffer space |

Table 2-4 lists the EDB entries for EDB-1 to EDB-3. EDB-0 registers are described separately.

Table 2-4. EDB Entries in RAM (n = 1 to 3)

| Offset | ENTRY NAME | DESCRIPTION |
|--------|------------|---------------------------------------|
| 07 | EPSIZXY_n | I/O endpoint_n: X/Y buffer size |
| 06 | EPBCTY_n | I/O endpoint_n: Y byte count |
| 05 | EPBBAY_n | I/O endpoint_n: Y buffer base address |
| 04 | SPARE | Not used |
| 03 | SPARE | Not used |
| 02 | EPBCTX_n | I/O endpoint_n: X byte count |
| 01 | EPBBAX_n | I/O endpoint_n: X buffer base address |
| 00 | EPCNF_n | I/O endpoint_n: configuration |

2.4.1 OEPCNF_n: Output Endpoint Configuration (n = 1 to 3)

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|-----|--------|------|-------|-------|-----|-----|
| UBME | ISO | TOGGLE | DBUF | STALL | USBIE | RSV | RSV |
| R/W | R/W | R/W | R/W | R/W | R/W | R/O | R/O |

| BIT | NAME | RESET | FUNCTION | |
|-----|--------|-------|--|---|
| 1–0 | RSV | 0 | Reserved | |
| 2 | USBIE | x | USB interrupt enable on transaction completion. Set/cleared by MCU. | |
| | | | USBIE = 0 | No interrupt |
| | | | USBIE = 1 | Interrupt on transaction completion |
| 3 | STALL | 0 | USB stall condition indication. Set/cleared by MCU. | |
| | | | STALL = 0 | No stall |
| | | | STALL = 1 | USB stall condition. If set by MCU, a STALL handshake is initiated and the bit is cleared by the MCU. |
| 4 | DBUF | x | Double buffer enable. Set/cleared by MCU. | |
| | | | DBUF = 0 | Primary buffer only (X-buffer only) |
| | | | DBUF = 1 | Toggle bit selects buffer |
| 5 | TOGGLE | x | USB toggle bit. This bit reflects the toggle sequence bit of DATA0, DATA1. | |
| 6 | ISO | x | ISO = 0 | Non-isochronous transfer. This bit must be cleared by the MCU because only non-isochronous transfer is supported. |
| | | | ISO = 1 | Isynchronous transfer. |
| 7 | UBME | x | UBM enable/disable bit. Set/cleared by the MCU. | |
| | | | UBME = 0 | UBM cannot use this endpoint. |
| | | | UBME = 1 | UBM can use this endpoint. |

2.4.2 OEPBAX_n: Output Endpoint X-Buffer Base Address (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| A10 | A9 | A8 | A7 | A6 | A5 | A4 | A3 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|---------|-------|---|
| 7–0 | A[10:3] | x | A[10:3] of X-buffer base address (padded with 3 LSB of zeros for a total of 11 bits). This value is set by the MCU. UBM or DMA uses this value as the start address of a given transaction. Furthermore, UBM or DMA does not change this value at the end of a transaction. |

2.4.3 OEPBCTX_n: Output Endpoint X-Byte Count (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 6–0 | C[6:0] | x | X-Buffer Byte count: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | NAK | x | NAK = 0 No valid data in buffer. Ready for host-out NAK = 1 Buffer contains a valid packet from host (host-out request is NAK) |

2.4.4 OEPBBAY_n: Output Endpoint Y-Buffer Base Address (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| A10 | A9 | A8 | A7 | A6 | A5 | A4 | A3 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|---------|-------|---|
| 7–0 | A[10:3] | x | A[10:3] of Y-buffer base address (padded with 3 LSB of zeros for a total of 11 bits). This value is set by the MCU. UBM or DMA uses this value as the start address of a given transaction. Furthermore, UBM or DMA does not change this value at the end of a transaction. |

2.4.5 OEPBCTY_n: Output Endpoint Y-Byte Count (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 6–0 | C[6:0] | x | Y-Buffer Byte count: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | NAK | x | NAK = 0 No valid data in buffer. Ready for host-out |
| | | | NAK = 1 Buffer contains a valid packet from host (host-out request is NAK). |

2.4.6 OEPSIZXY_n: Output Endpoint X-/Y-Buffer Size (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RSV | S6 | S5 | S4 | S3 | S2 | S1 | S0 |
| R/O | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 6–0 | S[6:0] | x | X- and Y-Buffer size: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | RSV | 0 | Reserved |

2.4.7 IEPCNF_n: Input Endpoint Configuration (n = 1 to 3)

| | | | | | | | |
|------|-----|--------|------|-------|-------|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| UBME | ISO | TOGGLE | DBUF | STALL | USBIE | RSV | RSV |
| R/W | R/W | R/W | R/W | R/W | R/W | R/O | R/O |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 1–0 | RSV | x | Reserved = 0 |
| 2 | USBIE | x | USB interrupt enable on transaction completion |
| | | | USBIE = 0 No interrupt |
| | | | USBIE = 1 Interrupt on transaction completion |
| 3 | STALL | 0 | USB stall condition indication. Set by UBM, but can be set/cleared by the MCU. |
| | | | STALL = 0 No stall |
| | | | STALL = 1 USB stall condition. If set by the MCU, a STALL handshake is initiated and the bit is cleared automatically. |
| 4 | DBUF | x | Double buffer enable |
| | | | DBUF = 0 Primary buffer only (X-buffer only) |
| | | | DBUF = 1 Toggle bit selects buffer |
| 5 | TOGGLE | x | USB toggle bit. This bit reflects the toggle sequence bit of DATA0, DATA1. |

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| BIT | NAME | RESET | FUNCTION | |
|-----|------|-------|---|---|
| 6 | ISO | x | ISO = 0 | Non-isochronous transfer. This bit must be cleared by the MCU because only non-isochronous transfer is supported. |
| 7 | UBME | x | UBM enable/disable bit. Set/cleared by the MCU. | |
| | | | UBME = 0 | UBM cannot use this endpoint. |
| | | | UBME = 1 | UBM can use this endpoint. |

2.4.8 IEPBBAX_n: Input Endpoint X-Buffer Base Address (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| A10 | A9 | A8 | A7 | A6 | A5 | A4 | A3 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|---------|-------|---|
| 7–0 | A[10:3] | x | A[10:3] of X-buffer base address (padded with 3 LSB of zeros for a total of 11 bits). This value is set by the MCU. UBM or DMA uses this value as the start address of a given transaction. Furthermore, UBM or DMA does not change this value at the end of a transaction. |

2.4.9 IEPCTX_n: Input Endpoint X-Byte Base Address (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 6–0 | C[6:0] | x | X-Buffer Byte count: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | NAK | x | NAK = 0 Buffer contains a valid packet for host-in transaction |
| | | | NAK = 1 Buffer is empty (host-in request is NAK) |

2.4.10 IEPBBAY_n: Input Endpoint Y-Buffer Base Address (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| A10 | A9 | A8 | A7 | A6 | A5 | A4 | A3 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|---------|-------|---|
| 7–0 | A[10:3] | x | A[10:3] of Y-buffer base address (padded with 3 LSB of zeros for a total of 11 bits). This value is set by the MCU. UBM or DMA uses this value as the start address of a given transaction. Furthermore, UBM or DMA does not change this value at the end of a transaction. |

2.4.11 IEPBCTY_n: Input Endpoint Y-Byte Count (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 6–0 | C[6:0] | x | X-BufferByte count: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | NAK | x | NAK = 0 Buffer contains a valid packet for host-in transaction |
| | | | NAK = 1 Buffer is empty (host-in request is NAK) |

2.4.12 IEPSIZXY_n: Input Endpoint X-/Y-Buffer Size (n = 1 to 3)

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RSV | S6 | S5 | S4 | S3 | S2 | S1 | S0 |
| R/O | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 6–0 | S[6:0] | x | X- and Y-Buffer size: 000 0000b → Count = 0 000 0001b → Count = 1 byte . . . 011 1111b → Count = 63 bytes 100 0000b → Count = 64 bytes Any value ≥ 100 0001b produces unpredictable results. |
| 7 | RSV | x | Reserved |

2.5 Endpoint-0 Descriptor Registers

Unlike EDB-1 to EDB-3, which are defined as memory entries in SRAM, endpoint-0 is described by a set of four registers (two for output and two for input). Table 2-5 defines the registers and their respective addresses used for EDB-0 description. EDB-0 has no *Base-Address Register*, because these addresses are hardwired to FEF8 and FEF0. Note that the bit positions have been preserved to provide consistency with EDB-n (n = 1 to 3).

Table 2-5. Input/Output EDB-0 Registers

| ADDRESS | REGISTER NAME | DESCRIPTION | BASE ADDRESS |
|---------|---------------|---|--------------|
| FF83 | OEPBCNT_0 | Output endpoint_0: byte-count register | FEF0 |
| FF82 | OEPCNFG_0 | Output endpoint_0: configuration register | |
| FF81 | IEPBCNT_0 | Input endpoint_0: byte-count register | FEF8 |
| FF80 | IEPCNFG_0 | Input endpoint_0: configuration register | |

2.5.1 IEPCNFG_0: Input Endpoint-0 Configuration Register

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|-----|--------|-----|-------|-------|-----|-----|
| UBME | RSV | TOGGLE | RSV | STALL | USBIE | RSV | RSV |
| R/W | R/O | R/O | R/O | R/W | R/W | R/O | R/O |

| BIT | NAME | RESET | FUNCTION | |
|-----|--------|-------|--|--|
| 1–0 | RSV | 0 | Reserved | |
| 2 | USBIE | 0 | USB interrupt enable on transaction completion. Set/cleared by the MCU | |
| | | | USBIE = 0 | No interrupt |
| | | | USBIE = 1 | Interrupt on transaction completion |
| 3 | STALL | 0 | USB stall condition indication. Set/cleared by the MCU | |
| | | | STALL = 0 | No stall |
| | | | STALL = 1 | USB stall condition. If set by the MCU, a STALL handshake is initiated and the bit is cleared automatically by the next setup transaction. |
| 4 | RSV | 0 | Reserved | |
| 5 | TOGGLE | 0 | USB toggle bit. This bit reflects the toggle sequence bit of DATA0, DATA1. | |
| 6 | RSV | 0 | Reserved | |
| 7 | UBME | 0 | UBM enable/disable bit. Set/cleared by the MCU | |
| | | | UBME = 0 | UBM cannot use this endpoint. |
| | | | UBME = 1 | UBM can use this endpoint. |

2.5.2 IEPBCNT_0: Input Endpoint-0 Byte-Count Register

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | RSV | RSV | RSV | C3 | C2 | C1 | C0 |
| R/W | R/O | R/O | R/O | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 3–0 | C[3:0] | 0000 | Byte count: 0000b → Count = 0 . . . 0111b → Count = 7 1000b → Count = 8 1001b to 1111b are reserved. (If used, defaults to 8) |
| 6–4 | RSV | 0 | Reserved |
| 7 | NAK | 1 | NAK = 0 Buffer contains a valid packet for host-in transaction. |
| | | | NAK = 1 Buffer is empty (host-in request is NAK). |

2.5.3 OEPCNFG_0: Output Endpoint-0 Configuration Register

| | | | | | | | |
|------|-----|--------|-----|-------|-------|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| UBME | RSV | TOGGLE | RSV | STALL | USBIE | RSV | RSV |
| R/W | R/O | R/O | R/O | R/W | R/W | R/O | R/O |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 1–0 | RSV | 0 | Reserved |
| 2 | USBIE | 0 | USB interrupt enable on transaction completion. Set/cleared by the MCU |
| | | | USBIE = 0 No interrupt |
| | | | USBIE = 1 Interrupt on transaction completion |
| 3 | STALL | 0 | USB stall condition indication. Set/cleared by the MCU |
| | | | STALL = 0 No stall |
| | | | STALL = 1 USB stall condition. If set by the MCU, a STALL handshake is initiated and the bit is cleared automatically. |
| 4 | RSV | 0 | Reserved |
| 5 | TOGGLE | 0 | USB toggle bit. This bit reflects the toggle sequence bit of DATA0, DATA1. |
| 6 | RSV | 0 | Reserved |
| 7 | UBME | 0 | UBM enable/disable bit. Set/cleared by the MCU |
| | | | UBME = 0 UBM cannot use this endpoint. |
| | | | UBME = 1 UBM can use this endpoint. |

2.5.4 OEPBCNT_0: Output Endpoint-0 Byte-Count Register

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| NAK | RSV | RSV | RSV | C3 | C2 | C1 | C0 |
| R/W | R/O | R/O | R/O | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 3–0 | C[3:0] | 0000 | Byte count: 0000b → Count = 0 . . 0111b → Count = 7 1000b → Count = 8 1001b to 1111b are reserved (if used, defaults to 8). |
| 6–4 | RSV | 0 | Reserved = 0 |
| 7 | NAK | 1 | NAK = 0 No valid data in buffer. Ready for host-out |
| | | | NAK = 1 Buffer contains a valid packet from host (NAK the host). |

2.6 USB Registers

2.6.1 FUNADR: Function Address Register

This register contains the device function address.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RSV | FA6 | FA5 | FA4 | FA3 | FA2 | FA1 | FA0 |
| R/O | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|---------|----------|--|
| 6–0 | FA[6:0] | 000 0000 | These bits define the current device address assigned to the function. The MCU writes a value to this register as a result of a <i>SET-ADDRESS</i> host command. |
| 7 | RSV | 0 | Reserved |

2.6.2 USBSTA: USB Status Register

All bits in this register are set by the hardware and are cleared by the MCU when writing a 1 to the proper bit location (writing a 0 has no effect). In addition, each bit can generate an interrupt if its corresponding mask bit is set (R/C notation indicates read and clear only by the MCU).

| | | | | | | | |
|------|------|------|-------|------|-------|-----|-------|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RSTR | SUSR | RESR | PWOFF | PWON | SETUP | RSV | STPOW |
| R/C | R/C | R/C | R/C | R/C | R/C | R/O | R/C |

| BIT | NAME | RESET | FUNCTION | |
|-----|-------|-------|--|---|
| 0 | STPOW | 0 | SETUP overwrite bit. Set by hardware when setup packet is received while there is already a packet in the setup buffer. | |
| | | | STPOW = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | STPOW = 1 | SETUP overwrite |
| 1 | RSV | 0 | Reserved | |
| 2 | SETUP | 0 | SETUP transaction received bit. As long as SETUP is 1, IN and OUT on endpoint-0 are NAK regardless of the value of their real NAK bits. | |
| | | | SETUP = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | SETUP = 1 | SETUP transaction has been received. |
| 3 | PWON | 0 | Power-on request for port 3. This bit indicates if power on to port 3 has been received. This bit generates a PWON interrupt (if enabled). | |
| | | | PWON = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | PWON = 1 | Power on to port 3 has been received. |
| 4 | PWOFF | 0 | Power-off request for port 3. This bit indicates whether power off to port 3 has been received. This bit generates a PWOFF interrupt (if enabled). | |
| | | | PWOFF = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | PWOFF = 1 | Power off to port 3 has been received. |
| 5 | RESR | 0 | Function resume request bit | |
| | | | RESR = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | RESR = 1 | Function resume is detected. |
| 6 | SUSR | 0 | Function suspended request bit. This bit is set in response to a global or selective suspend condition. | |
| | | | SUSR = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | SUSR = 1 | Function suspend is detected. |
| 7 | RSTR | 0 | Function reset request bit. This bit is set in response to host initiating a port reset. This bit is not affected by USB function reset. | |
| | | | RSTR = 0 | MCU can clear this bit by writing a 1. (Writing 0 has no effect.) |
| | | | RSTR = 1 | Function reset is detected. |

2.6.3 USBMSK: USB Interrupt Mask Register

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|------|------|-------|------|-------|-----|-------|
| RSTR | SUSR | RESR | PWOFF | PWON | SETUP | RSV | STPOW |
| R/W | R/W | R/W | R/W | R/W | R/W | R/O | R/W |

| BIT | NAME | RESET | FUNCTION | |
|-----|-------|-------|--------------------------------------|-------------------------------------|
| 0 | STPOW | 0 | SETUP overwrite interrupt enable bit | |
| | | | STPOW = 0 | STPOW interrupt disabled |
| | | | STPOW = 1 | STPOW interrupt enabled |
| 1 | RSV | 0 | Reserved = 0 | |
| 2 | SETUP | 0 | SETUP interrupt enable bit | |
| | | | SETUP = 0 | SETUP interrupt disabled |
| | | | SETUP = 1 | SETUP interrupt enabled |
| 3 | PWON | 0 | Power-on interrupt enable bit | |
| | | | PWON = 0 | PWON interrupt disabled |
| | | | PWON = 1 | PWON interrupt enabled |
| 4 | PWOFF | 0 | Power-off interrupt enable bit | |
| | | | PWOFF = 0 | PWOFF interrupt disabled |
| | | | PWOFF = 1 | PWOFF interrupt enabled |
| 5 | RESR | 0 | Function resume interrupt enable | |
| | | | RESR = 0 | Function resume interrupt disabled |
| | | | RESR = 1 | Function resume interrupt enabled |
| 6 | SUSR | 0 | Function suspend interrupt enable | |
| | | | SUSR = 0 | Function suspend interrupt disabled |
| | | | SUSR = 1 | Function suspend interrupt enabled |
| 7 | RSTR | 0 | Function reset interrupt enable | |
| | | | RSTR = 0 | Function reset interrupt disabled |
| | | | RSTR = 1 | Function reset interrupt enabled |

2.6.4 USBCTL: USB Control Register

Unlike the other registers, this register is cleared by the power-up-reset signal only. The USB reset cannot reset this register (see the reset diagram in [Figure 2-2](#)).

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|-----|------|-------|-----|-----|-----|-----|
| CONT | RSV | RWUP | FRSTE | RWE | B/S | SIR | DIR |
| R/W | R/O | R/W | R/W | R/W | R/O | R/W | R/W |

| BIT | NAME | RESET | FUNCTION | |
|-----|------|-------|---|--|
| 0 | DIR | 0 | As a response to a setup packet, the MCU decodes the request and sets or clears this bit to reflect the data transfer direction. | |
| | | | DIR = 0 | USB data OUT transaction (from host to TUSB3210) |
| | | | DIR = 1 | USB data IN transaction (from TUSB3210 to host) |
| 1 | SIR | 0 | SETUP interrupt status bit. This bit is controlled by the MCU to indicate to the hardware when the SETUP interrupt is being served. | |
| | | | SIR = 0 | SETUP interrupt is not served. MCU clears this bit before exiting the SETUP interrupt routine. |
| | | | SIR = 1 | SETUP interrupt is in progress. MCU sets this bit when servicing the SETUP interrupt. |
| 2 | B/S | 0 | Bus-/self-power control bit | |
| | | | B/S = 0 | The device is bus-powered. |
| | | | B/S = 1 | The device is self-powered. |

| BIT | NAME | RESET | FUNCTION | |
|-----|-------|-------|---|---|
| 3 | RWE | 0 | Remote wake-up enable bit | |
| | | | RWE = 0 | MCU clears this bit when host sends command to clear the feature. |
| | | | RWE = 1 | MCU writes 1 to this bit when host sends <i>set device feature command</i> to enable the remote wake-up feature |
| 4 | FRSTE | 1 | Function reset connection bit. This bit connects/disconnects the USB function reset from the MCU reset. | |
| | | | FRSTE = 0 | Function reset is not connected to the MCU reset. |
| | | | FRSTE = 1 | Function reset is connected to the MCU reset. |
| 5 | RWUP | 0 | Device remote wake-up request. This bit is set by the MCU and is cleared automatically. | |
| | | | RWUP = 0 | Writing a 0 to this bit has no effect. |
| | | | RWUP = 1 | When the MCU writes a 1, a remote wake-up pulse is generated. |
| 6 | RSV | 0 | Reserved | |
| 7 | CONT | 0 | Connect/disconnect bit | |
| | | | CONT = 0 | Upstream port is disconnected. Pullup disabled |
| | | | CONT = 1 | Upstream port is connected. Pullup enabled |

2.6.5 VIDSTA: VID/PID Status Register

This register is used to read the value on four external pins. The firmware can use this value to select one of the vendor identification/product identifications (VID/PID) stored in memory. The TUSB3210 supports up to 16 unique VID/PIDs with application code to support different products. This provides a unique opportunity for original equipment manufacturers (OEMs) to have one device to support up to 16 different product lines by using S0–S3 to select VID/PID and behavioral application code for the selected product.

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----|-----|-----|-----|-----|-----|-----|-----|
| RSV | RSV | RSV | RSV | S3 | S2 | S1 | S0 |
| R/O | R/O | R/O | R/O | R/O | R/O | R/O | R/O |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 3–0 | S[3:0] | x | VID/PID selection bits. These bits reflect the status of the external pins as defined by Table 2-6. Note that a pin tied low is reflected as a 0 and a pin tied high is reflected as a 1. |
| 7–4 | RSV | 0 | Reserved = 0 |

Table 2-6. External Pin Mapping to S[3:0] in VIDSTA Register

| VIDSTA REGISTER, S[3:0] | PIN | | COMMENTS |
|-------------------------|-----|------|------------------------------------|
| | NO. | NAME | |
| S0 | 58 | P3.0 | Dual function P3.0 I/O or S0 input |
| S1 | 57 | P3.1 | Dual function P3.1 I/O or S1 input |
| S2 | 8 | S2 | S2-pin is input |
| S3 | 9 | S3 | S3-pin is input |

2.7 Function Reset and Power-Up Reset Interconnect

Figure 2-2 represents the logical connection of the USB-function-reset (\overline{USBR}) and power-up-reset (\overline{RST}) pins. The internal \overline{RESET} signal is generated from the \overline{RST} pin (\overline{PURS} signal) or from the USB-reset (\overline{USBR} signal). The \overline{USBR} can be enabled or disabled by the FRSTE bit in the USBCTL register (on power up FRSTE = 0). The internal \overline{RESET} is used to reset all registers and logic, with the exception of the USBCTL and MISCTL registers. The USBCTL and MCU configuration registers (MCNFG) are cleared by the \overline{PURS} signal only.

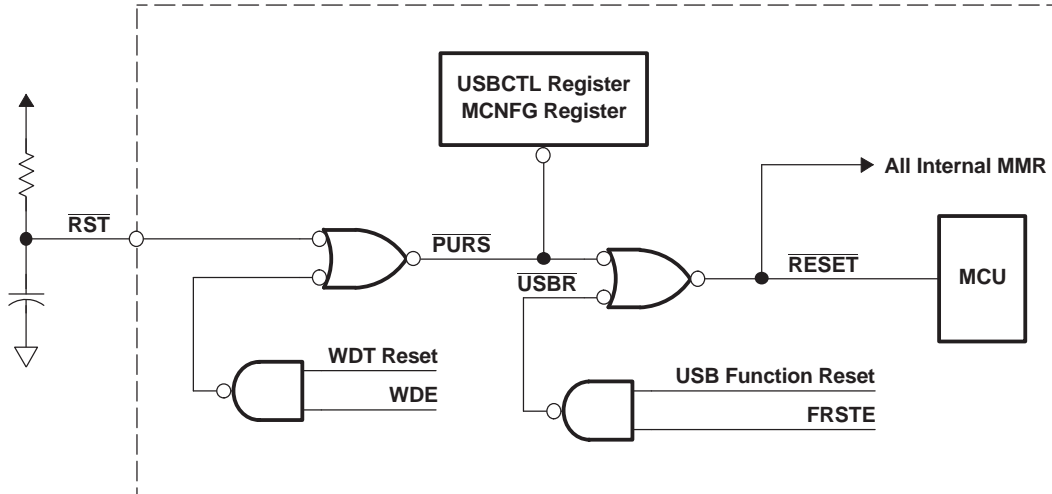


Figure 2-2. Reset Diagram

2.8 Pullup Resistor Connect/Disconnect

After reading firmware into RAM, the TUSB3210 can re-enumerate using the new firmware (no need to physically disconnect and re-connect the cable). Figure 2-3 shows an equivalent circuit implementation for *Connect* and *Disconnect* from a USB upstream port (also see Figure 4-3b). When the CONT bit in the USBCTL register is 1, the CMOS driver sources V_{DD} to the pullup resistor (PUR pin) presenting a normal connect condition to the USB hub (high speed). When the CONT bit is 0, the PUR pin is driven low. In this state, the 1.5-k Ω resistor is connected to GND, resulting in device *disconnection* state. The PUR driver is a CMOS driver that can provide $V_{DD} - 0.1$ V minimum at 8 mA of source current.

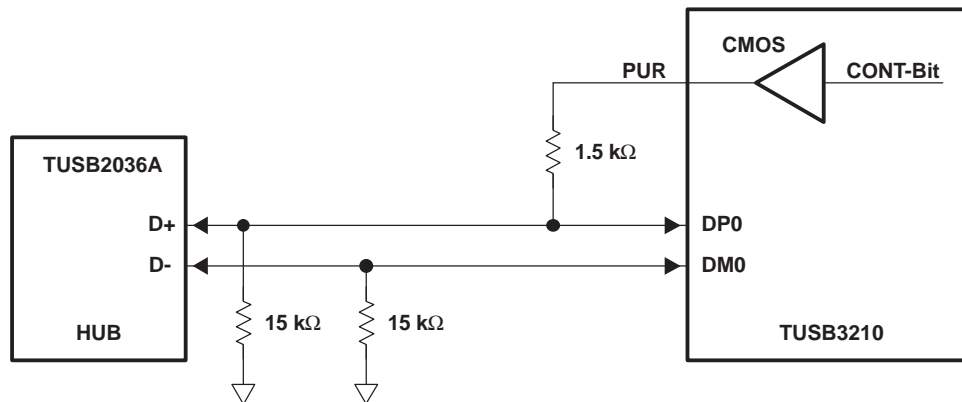


Figure 2-3. Pullup Resistor Connect/Disconnect Circuit

2.9 8052 Interrupt and Status Registers

All seven 8052-standard interrupt sources are preserved. SIE is the standard interrupt enable register, which controls the seven interrupt sources. All the additional interrupt sources are connected together as an OR to generate $\overline{INT0}$. The $\overline{INT0}$ signal is provided to interrupt the MCU (see interrupt connection diagram, Figure 2-4).

Table 2-7. 8052 Interrupt Location Map

| INTERRUPT SOURCE | DESCRIPTION | START ADDRESS | COMMENTS |
|------------------|-------------------|---------------|----------|
| ET2 | Timer-2 interrupt | 002Bh | |

Table 2-7. 8052 Interrupt Location Map (continued)

| INTERRUPT SOURCE | DESCRIPTION | START ADDRESS | COMMENTS |
|-------------------|------------------------------------|---------------|-----------------------------------|
| ES | UART interrupt | 0023h | |
| ET1 | Timer-1 interrupt | 001Bh | |
| EX1 | Internal $\overline{INT1}$ or INT1 | 0013h | Used for P2[7:0] interrupt |
| ET0 | Timer-0 interrupt | 000Bh | |
| $\overline{INT0}$ | Internal $\overline{INT0}$ | 0003h | Used for all internal peripherals |
| Reset | | 0000h | |

2.9.1 8052 Standard Interrupt Enable Register

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-------------------|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| EA | RSV | ET2 | ES | ET1 | EX1 | ET0 | $\overline{INT0}$ |
| R/W | R/O | R/O | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|-------------------|-------|--|
| 0 | $\overline{INT0}$ | 0 | Enable or disable interrupt-0 |
| | | | $\overline{INT0} = 0$ Interrupt-0 is disabled. |
| | | | $\overline{INT0} = 1$ Interrupt-0 is enabled. |
| 1 | ET0 | 0 | Enable or disable timer-0 interrupt |
| | | | ET0 = 0 Timer-0 interrupt is disabled. |
| | | | ET0 = 1 Timer-0 interrupt is enabled. |
| 2 | EX1 | 0 | Enable or disable interrupt-1 |
| | | | EX1 = 0 Interrupt-1 is disabled. |
| | | | EX1 = 1 Interrupt-1 is enabled. |
| 3 | ET1 | 0 | Enable or disable timer-1 interrupt |
| | | | ET1 = 0 Timer-1 interrupt is disabled. |
| | | | ET1 = 1 Timer-1 interrupt is enabled. |
| 4 | ES | 0 | Enable or disable serial port interrupts |
| | | | ES = 0 Serial port interrupt is disabled. |
| | | | ES = 1 Serial port interrupt is enabled. |
| 5 | ET2 | 0 | Enable or disable timer-2 interrupt |
| | | | ET1 = 0 Timer-2 interrupt is disabled. |
| | | | ET1 = 1 Timer-2 interrupt is enabled. |
| 6 | RSV | 0 | Reserved |
| 7 | EA | 0 | Enable or disable all interrupts (global disable) |
| | | | EA = 0 Disable all interrupts. |
| | | | EA = 1 Each interrupt source is individually controlled. |

2.9.2 Additional Interrupt Sources

All nonstandard 8052 interrupts (USB, I²C, etc.) are connected as an OR to generate an internal $\overline{INT0}$. It must be noted that the external $\overline{INT0}$ and $\overline{INT1}$ are not used. Furthermore, $\overline{INT0}$ must be programmed as an active-low level interrupt (not edge-triggered). A vector interrupt register is provided to identify all interrupt sources (see vector interrupt register definition, [Section 2.9.3](#)). Up to 64 interrupt vectors are provided. It is the responsibility of the MCU to read the vector and dispatch the proper interrupt routine.

2.9.3 VECINT: Vector Interrupt Register

This register contains a vector value identifying the internal interrupt source that trapped to location 0003h. Writing any value to this register removes the vector and updates the next vector value (if another interrupt is pending). Note that the vector value is offset. Therefore, its value is in increments of two (bit 0 is set to 0). When no interrupt is pending, the vector is set to 00h. [Table 2-8](#) is a table of the vector interrupt values. As shown, the interrupt vector is divided into two fields; I[2:0] and G[3:0]. The I-field defines the interrupt source within a group (on a first-come, first-served basis) and the G-field defines the group number. Group G0 is the lowest and G15 is the highest priority.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| G3 | G2 | G1 | G0 | I2 | I1 | I0 | RSV |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/O |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 0 | RSV | 0 | Reserved |
| 3–1 | I[2:0] | 000 | This field defines the interrupt source in a given group. See Table 2-8 : Vector Interrupt Values. Bit 0 is always 0; therefore, vector values are offset by two. |
| 7–4 | G[3:0] | 0000 | This field defines the interrupt group. I[2:0] and G[3:0] combine to produce the actual interrupt vector. |

Table 2-8. Vector Interrupt Values

| G[3:0] (Hex) | I[2:0] (Hex) | VECTOR (Hex) | INTERRUPT SOURCE |
|--------------|--------------|--------------|--------------------------------|
| 0 | 0 | 00 | No interrupt |
| 1 | 0 | 10 | RESERVED |
| 1 | 1 | 12 | Output endpoint-1 |
| 1 | 2 | 14 | Output endpoint-2 |
| 1 | 3 | 16 | Output endpoint-3 |
| 1 | 4–7 | 18–1E | RESERVED |
| 2 | 0 | 20 | RESERVED |
| 2 | 1 | 22 | Input endpoint-1 |
| 2 | 2 | 24 | Input endpoint-2 |
| 2 | 3 | 26 | Input endpoint-3 |
| 2 | 4–7 | 28–2E | RESERVED |
| 3 | 0 | 30 | STPOW packet received |
| 3 | 1 | 32 | SETUP packet received |
| 3 | 2 | 34 | PWON interrupt |
| 3 | 3 | 36 | PWOFF interrupt |
| 3 | 4 | 38 | RESR interrupt |
| 3 | 5 | 3A | SUSR interrupt |
| 3 | 6 | 3C | RSTR interrupt |
| 3 | 7 | 3E | RESERVED |
| 4 | 0 | 40 | I ² C TXE interrupt |
| 4 | 1 | 42 | I ² C RXF interrupt |
| 4 | 2 | 44 | Input endpoint-0 |
| 4 | 3 | 46 | Output endpoint-0 |
| 4 | 4–7 | 48–4E | RESERVED |
| 5–F | X | 90–FE | RESERVED |

2.9.4 Logical Interrupt Connection Diagram ($\overline{INT0}$)

Figure 2-4 represents the logical connection of the interrupt sources and the relation of the logical connection with $\overline{INT0}$. The priority encoder generates an 8-bit vector, corresponding to 64 interrupt sources (not all are used). The interrupt priorities are hard wired. Vector 46h is the highest and 12h is the lowest. Table 2-8 lists the interrupt source for each valid interrupt vector.

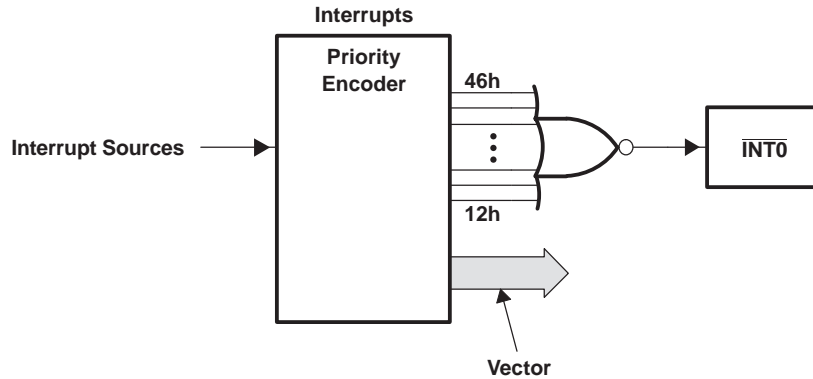


Figure 2-4. Internal Vector Interrupt ($\overline{INT0}$)

2.9.5 P2[7:0], P3.3 Interrupt ($\overline{INT1}$)

Figure 2-5 illustrates the conceptual port-2 interrupt. All port-2 input signals are connected in a logical OR to generate the $\overline{INT1}$ interrupt. Note that the inputs are active-low and $\overline{INT1}$ is programmed as a level-triggered interrupt. In addition, $\overline{INT1}$ is connected to the suspend/resume logic for remote wake-up support. As illustrated, the XINT bit in the MCU configuration register (MCNFG) is used to select the EX1 interrupt source. When XINT = 0, P3.3 is the source, and when XINT = 1, P2[7:0] is the source. The programmable delay is determined by the setting of I[3:0] in the INTCFG register.

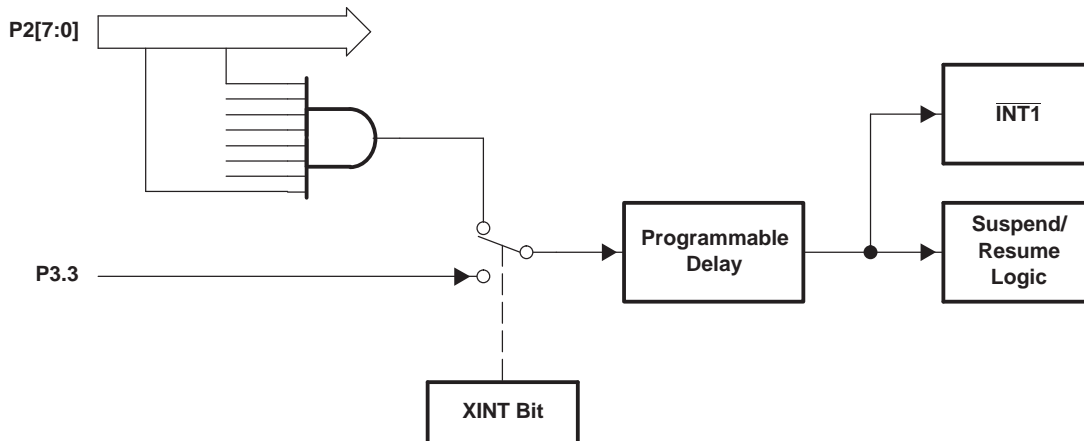


Figure 2-5. P2[7:0], P3.3 Input Port Interrupt Generation

2.10 I²C Registers

The TUSB3210 only supports a master-slave relationship; therefore, it does not support bus arbitration.

2.10.1 I2CSTA: I²C Status and Control Register

This register is used to control the stop condition for read and write operations. In addition, it provides transmitter and receiver handshake signals with their respective interrupt enable bits.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RXF | RIE | ERR | 1/4 | TXE | TIE | SRD | SWR |
| R/C | R/W | R/C | R/W | R/C | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION | |
|-----|------|-------|--|--|
| 0 | SWR | 0 | Stop write condition. This bit defines whether the I ² C controller generates a stop condition when data from the I2CDAO register is transmitted to an external device. | |
| | | | SWR = 0 | Stop condition is not generated when data from the I2CDAO register is shifted out to an external device. |
| | | | SWR = 1 | Stop condition is generated when data from the I2CDAO register is shifted out to an external device. |
| 1 | SRD | 0 | Stop read condition. This bit defines whether the I ² C controller generates a stop condition when data is received and loaded into I2CDAI register. | |
| | | | SRD = 0 | Stop condition is not generated when data from SDA line is shifted into the I2CDAI register. |
| | | | SRD = 1 | Stop condition is generated when data from SDA line is shifted into the I2CDAI register. |
| 2 | TIE | 0 | I ² C transmitter empty interrupt enable | |
| | | | TIE = 0 | Interrupt disabled |
| | | | TIE = 1 | Interrupt enabled |
| 3 | TXE | 1 | I ² C transmitter empty. This bit indicates that data can be written to the transmitter. It can be used for polling or it can generate an interrupt. | |
| | | | TXE = 0 | Transmitter is full. This bit is cleared when the MCU writes a byte to the I2CDAO register. |
| | | | TXE = 1 | Transmitter is empty. The I ² C controller sets this bit when the content of the I2CDAO register is copied to the SDA shift register. |
| 4 | 1/4 | 0 | Bus speed selection | |
| | | | 1/4 = 0 | 100-kHz bus speed |
| | | | 1/4 = 1 | 400-kHz bus speed |
| 5 | ERR | 0 | Bus error condition. This bit is set by the hardware when the device does not respond. It is cleared by the MCU. | |
| | | | ERR = 0 | No bus error |
| | | | ERR = 1 | Bus error condition has been detected. Clears when the MCU writes a 1. Writing a 0 has no effect. |
| 6 | RIE | 0 | I ² C receiver ready interrupt enable | |
| | | | RIE = 0 | Interrupt disabled |
| | | | RIE = 1 | Interrupt enabled |
| 7 | RXF | 0 | I ² C receiver full. This bit indicates that the receiver contains new data. It can be used for polling or it can generate an interrupt. | |
| | | | RXF = 0 | Receiver is empty. This bit is cleared when the MCU reads the I2CDAI register. |
| | | | RXF = 1 | Receiver contains new data. This bit is set by the I ² C controller when the received serial data has been loaded into the I2CDAI register. |

2.10.2 I2CADR: I²C Address Register

This register holds the device address and the read/write command bit.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| A6 | A5 | A4 | A3 | A2 | A1 | A0 | R/W |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|----------|--|
| 0 | R/W | 0 | Read/write command bit |
| | | | R/W = 0 Write operation |
| | | | R/W = 1 Read operation |
| 7–1 | A[6:0] | 000 0000 | Seven address bits for device addressing |

2.10.3 I2CDAI: I²C Data-Input Register

This register holds the received data from an external device.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| R/O | R/O | R/O | R/O | R/O | R/O | R/O | R/O |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|--|
| 7–0 | D[7:0] | 0 | 8-bit input data from an I ² C device |

2.10.4 I2CDAO: I²C Data-Output Register

This register holds the data to be transmitted to an external device. Writing to this register starts the transfer on the SDA line.

| | | | | | | | |
|-----|-----|-----|-----|-----|-----|-----|-----|
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| R/W | R/W | R/W | R/W | R/W | R/W | R/W | R/W |

| BIT | NAME | RESET | FUNCTION |
|-----|--------|-------|---|
| 7–0 | D[7:0] | 0 | 8-bit output data to an I ² C device |

2.11 Read/Write Operations

2.11.1 Read Operation (Serial EEPROM)

A serial read requires a *dummy* byte write sequence to load in the 16-bit data word address. Once the device address word and data address word are clocked out and acknowledged by the device, the MCU starts a current address sequence. The following describes the sequence of events to accomplish this transaction:

Device Address + EEPROM [High Byte]

1. The MCU sets I2CSTA[SRD] = 0. This prevents the I²C controller from generating a stop condition after the content of the I2CDAI register is received.
2. The MCU sets I2CSTA[SWR] = 0. This prevents the I²C controller from generating a stop condition after the content of the I2CDAO register is transmitted.
3. The MCU writes the device address (R/W bit = 0) to the I2CADR register (write operation).
4. The MCU writes the high byte of the EEPROM address into the I2CDAO register, starting the transfer on the SDA line.
5. The TXE bit in I2CSTA is cleared, indicating busy.
6. The content of the I2CADR register is transmitted to the EEPROM (preceded by start condition on

SDA).

7. The content of the I2CDAO register is transmitted to the EEPROM (EEPROM address).
8. The TXE bit in I2CSTA is set, and interrupts the MCU, indicating that the I2CDAO register has been transmitted.
9. No stop condition is generated.

EEPROM [Low Byte]

1. The MCU writes the low byte of the EEPROM address into the I2CDAO register.
2. The TXE bit in I2CSTA is cleared, indicating busy.
3. The content of the I2CDAO register is transmitted to the device (EEPROM address).
4. The TXE bit in I2CSTA is set, and interrupts the MCU, indicating that the I2CDAO register has been transmitted.
5. This completes the *dummy* write operation. At this point, the EEPROM address is set and the MCU can do a single or a sequential read operation.

2.11.2 Current Address Read Operation

Once the EEPROM address is set, the MCU can read a single byte by executing the following steps:

1. The MCU sets I2CSTA[SRD] = 1, forcing the I²C controller to generate a stop condition after the I2CDAI register is received.
2. The MCU writes the device address (R/W bit = 1) to the I2CADR register (read operation).
3. The MCU writes a dummy byte to the I2CDAO register, starting the transfer on the SDA line.
4. The RXF bit in I2CSTA is cleared.
5. The content of the I2CADR register is transmitted to the device, preceded by a start condition on SDA.
6. Data from the EEPROM is latched into the I2CDAI register (stop condition is transmitted).
7. The RXF bit in I2CSTA is set, and interrupts the MCU, indicating that the data is available.
8. The MCU reads the I2CDAI register. This clears the RXF bit (I2CSTA[RXF] = 0).

2.11.3 Sequential Read Operation

Once the EEPROM address is set, the MCU can execute a sequential read operation by executing the following steps (Note: this example illustrates a 32-byte sequential read):

1. Device Address
 - a. The MCU sets I2CSTA[SRD] = 0. This prevents the I²C controller from generating a stop condition after the I2CDAI register is received.
 - b. The MCU writes the device address (R/W bit = 1) to the I2CADR register (read operation).
 - c. The MCU writes a dummy byte to the I2CDAO register, starting the transfer on the SDA line.
 - d. The RXF bit in I2CSTA is cleared.
 - e. The content of the I2CADR register is transmitted to the device (preceded by a start condition on SDA).
2. N-Byte Read (31 bytes)
 - a. Data from the device is latched into the I2CDAI register (stop condition is not transmitted).
 - b. The RXF bit in I2CSTA is set and interrupts the MCU, indicating that data is available.
 - c. The MCU reads the I2CDAI register, clearing the RXF bit (I2CSTA[RXF] = 0).
 - d. This operation repeats 31 times.
3. Last-Byte Read (byte no. 32)
 - a. The MCU sets I2CSTA[SRD] = 1. This forces the I²C controller to generate a stop condition after the I2CDAI register is received.
 - b. Data from the device is latched into the I2CDAI register (stop condition is transmitted).
 - c. The RXF bit in I2CSTA is set and interrupts the MCU, indicating that data is available.

- d. The MCU reads the I2CDAI register, clearing the RXF bit (I2CSTA[RXF] = 0).

2.11.4 Write Operation (Serial EEPROM)

The byte write operation involves three phases: 1) device address + EEPROM [high byte] phase, 2) EEPROM [low byte] phase, and 3) EEPROM [DATA]. The following describes the sequence of events to accomplish the byte write transaction:

Device Address + EEPROM [High Byte]

1. The MCU sets I2CSTA[SWR] = 0. This prevents the I²C controller from generating a stop condition after the content of the I2CDAO register is transmitted.
2. The MCU writes the device address (R/W bit = 0) to the I2CADR register (write operation).
3. The MCU writes the high byte of the EEPROM address into the I2CDAO register, starting the transfer on the SDA line.
4. The TXE bit in I2CSTA is cleared, indicating busy.
5. The content of the I2CADR register is transmitted to the device (preceded by a start condition on SDA).
6. The content of the I2CDAO register is transmitted to the device (EEPROM high-address).
7. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been transmitted.

EEPROM [Low Byte]

1. The MCU writes the low byte of the EEPROM address into the I2CDAO register.
2. The TXE bit in I2CSTA is cleared, indicating busy.
3. The content of the I2CDAO register is transmitted to the device (EEPROM address).
4. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been transmitted.

EEPROM [DATA]

1. The MCU sets I2CSTA[SWR] = 1. This forces the I²C controller to generate a stop condition after the content of the I2CDAO register is transmitted.
2. The MCU writes the DATA to be written to the EEPROM into the I2CDAO register.
3. The TXE bit in I2CSTA is cleared, indicating busy.
4. The content of the I2CDAO register is transmitted to the device (EEPROM data).
5. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been transmitted.
6. The I²C controller generates a stop condition after the content of the I2CDAO register is transmitted.

2.11.5 Page Write Operation

The page write operation is initiated the same way as byte write, with the exception that a stop condition is not generated after the first EEPROM [DATA] is transmitted. The following describes the sequence of writing 32 bytes in page mode:

Device Address + EEPROM [High Byte]

1. The MCU sets I2CSTA[SWR] = 0. This prevents the I²C controller from generating a stop condition after the content of the I2CDAO register is transmitted.
2. The MCU writes the device address (R/W bit = 0) to the I2CADR register (write operation).
3. The MCU writes the high byte of the EEPROM address into the I2CDAO register.
4. The TXE bit in I2CSTA is cleared, indicating busy.
5. The content of the I2CADR register is transmitted to the device (preceded by a start condition on SDA).
6. The content of the I2CDAO register is transmitted to the device (EEPROM address).
7. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been sent.

EEPROM [Low Byte]

1. The MCU writes the low byte of the EEPROM address into the I2CDAO register.
2. The TXE bit in I2CSTA is cleared, indicating busy.
3. The content of the I2CDAO register is transmitted to the device (EEPROM address).
4. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been sent.

31 Bytes EEPROM [DATA]

1. The MCU writes the DATA to be written to the EEPROM into the I2CDAO register.
2. The TXE bit in I2CSTA is cleared, indicating busy.
3. The content of the I2CDAO register is transmitted to the device (EEPROM data).
4. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been sent.
5. This operation repeats 31 times.

Last Byte EEPROM [DATA]

1. The MCU sets I2CSTA[SWR] = 1. This forces the I²C controller to generate a stop condition after the content of the I2CDAO register is transmitted.
2. The MCU writes the last DATA byte to be written to the EEPROM into the I2CDAO register.
3. The TXE bit in I2CSTA is cleared, indicating busy.
4. The content of the I2CDAO register is transmitted to the EEPROM (EEPROM data).
5. The TXE bit in I2CSTA is set and interrupts the MCU, indicating that the I2CDAO register has been sent.
6. The I²C controller generates a stop condition after the content of the I2CDAO register is transmitted, terminating the 32-byte page write operation.

3 Specifications

3.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|----------|----------------------|------|----------------|------|
| V_{CC} | Supply voltage | -0.5 | 4 | V |
| V_I | Input voltage | -0.5 | $V_{CC} + 0.5$ | V |
| V_O | Output voltage | -0.5 | $V_{CC} + 0.5$ | V |
| I_{IK} | Input clamp current | | ± 20 | mA |
| I_{OK} | Output clamp current | | ± 20 | mA |
| | Storage temperature | -65 | 150 | °C |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

3.2 Commercial Operating Conditions

| PARAMETER | | MIN | NOM | MAX | UNIT |
|-----------|--------------------------|-----|-----|----------|------|
| V_{CC} | Supply voltage | 3 | 3.3 | 3.6 | V |
| V_I | Input voltage | 0 | | V_{CC} | V |
| V_{IH} | High-level input voltage | 2 | | V_{CC} | V |
| V_{IL} | Low-level input voltage | 0 | | 0.8 | V |
| T_A | Operating temperature | 0 | | 70 | °C |

3.3 Electrical Characteristics

$T_A = 25^\circ\text{C}$, $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$, $\text{GND} = 0\text{ V}$

| PARAMETER | | TEST CONDITIONS | MIN | NOM | MAX | UNIT |
|--------------|------------------------------------|----------------------------|----------------|-----|---------|---------------|
| V_{OH} | High-level output voltage | $I_{OH} = -4\text{ mA}$ | $V_{CC} - 0.5$ | | | V |
| V_{OL} | Low-level output voltage | $I_{OL} = 4\text{ mA}$ | | | 0.5 | V |
| V_{IT+} | Positive input threshold voltage | $V_I = V_{IH}$ | | | 2 | V |
| V_{IT-} | Negative input threshold voltage | $V_I = V_{IL}$ | 0.8 | | | V |
| V_{hys} | Hysteresis ($V_{IT+} - V_{IT-}$) | $V_I = V_{IH}$ | | 1 | | V |
| I_{IH} | High-level input current | $V_I = V_{IH}$ | | | ± 1 | μA |
| I_{IL} | Low-level input current | $V_I = V_{IL}$ | | | ± 1 | μA |
| I_{OZ} | Output leakage current (Hi-Z) | $V_I = V_{CC}$ or V_{SS} | | | 10 | μA |
| C_I | Input capacitance | | | 5 | | pF |
| C_O | Output capacitance | | | 7 | | pF |
| I_{CC} | Quiescent | | | 25 | 45 | mA |
| I_{CCx} | Suspend | | | | 45 | μA |
| $I_{CCx1.8}$ | Suspend 1.8 VDD | | | | 1 | μA |

4 Application

4.1 Examples

Figure 4-1 illustrates the port-3 pins that are assigned to drive the four example LEDs. For the connection example shown, P3[5:2] can sink up to 8 mA each (open-drain outputs). Figure 4-2 illustrates the partial connection bus power mode. Figure 4-3 shows the USB upstream connection, and Figure 4-4 illustrates the downstream connection (only one port shown).

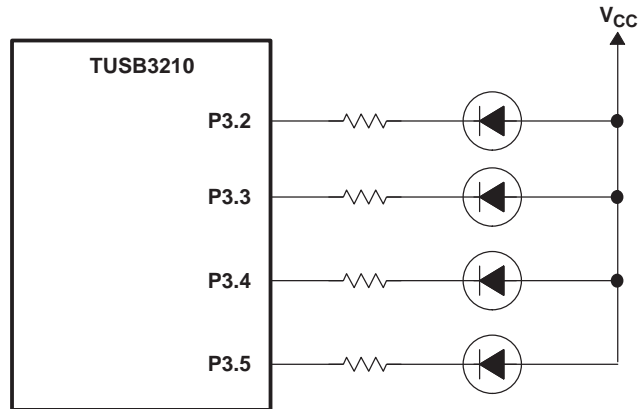


Figure 4-1. Example LED Connection

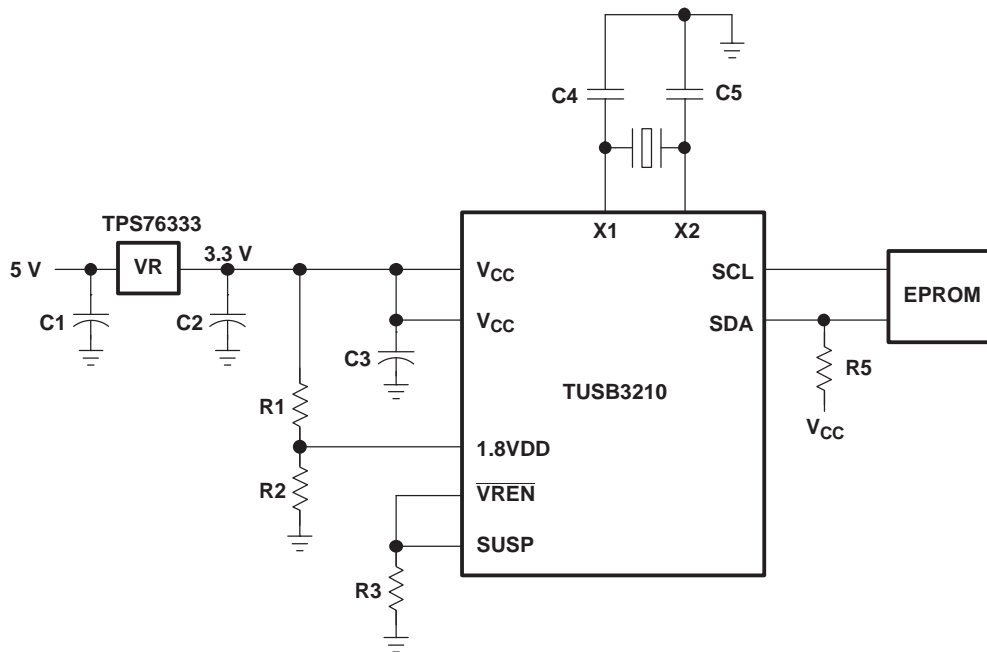


Figure 4-2. Partial Connection Bus Power Mode

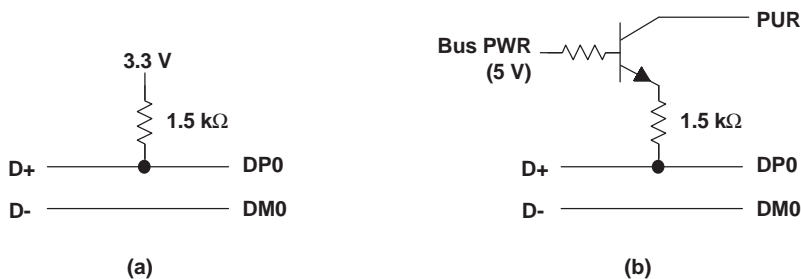


Figure 4-3. Upstream Connection (a) Non-Switching Power Mode (b) Switching Power Mode

4.2 Reset Timing

There are three requirements for the reset signal timing. First, the minimum reset pulse duration is 100 μ s. At power up, this time is measured from the time the power ramps up to 90% of the nominal V_{CC} until the reset signal exceeds 1.2 V. The second requirement is that the clock must be valid during the last 60 μ s of the reset window. The third requirement is that, according to the USB specification, the device must be ready to respond to the host within 100 ms. This means that within the 100-ms window, the device must come out of reset, load any pertinent data from the I²C EEPROM device, and transfer execution to the application firmware if any is present. Because the latter two events can require significant time, the amount of which can change from system to system, TI recommends having the device come out of reset within 30 ms, leaving 70 ms for the other events to complete. This means the reset signal should rise to 1.8 V within 30 ms.

These requirements are depicted in [Figure 4-4](#). Notice that when using a 12-MHz crystal or the 48-MHz oscillator, the clock signal may take several milliseconds to ramp up and become valid after power up. Therefore, the reset window may need to be elongated up to 10 ms or more to ensure that there is a 60- μ s overlap with a valid clock.

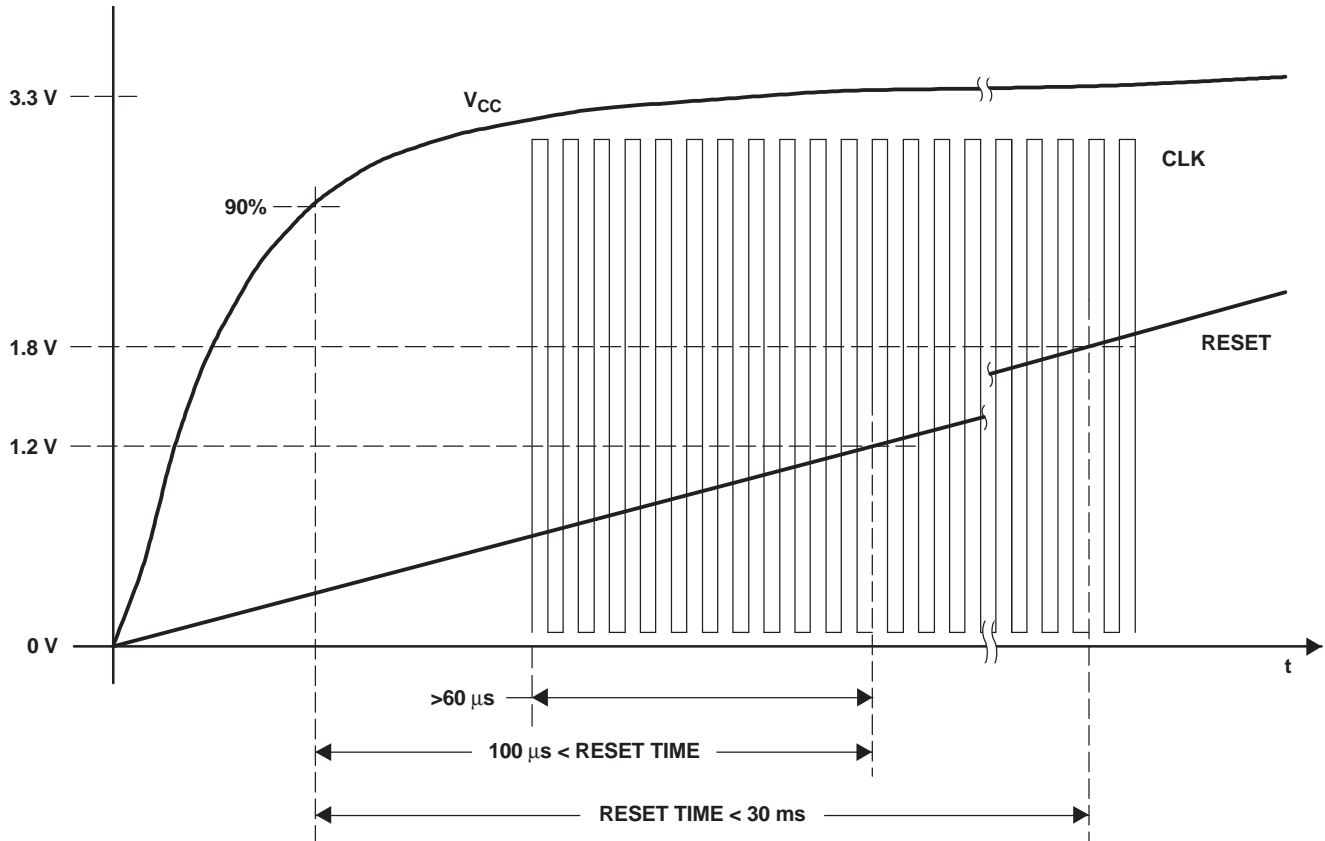


Figure 4-4. Reset Timing

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish | MSL Peak Temp (3) | Op Temp (°C) | Top-Side Markings (4) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-------------------------|------------------|----------------------|--------------|--------------------------|-------------------------|
| TUSB3210PM | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | 0 to 70 | TUSB3210PM | Samples |
| TUSB3210PMG4 | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | 0 to 70 | TUSB3210PM | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

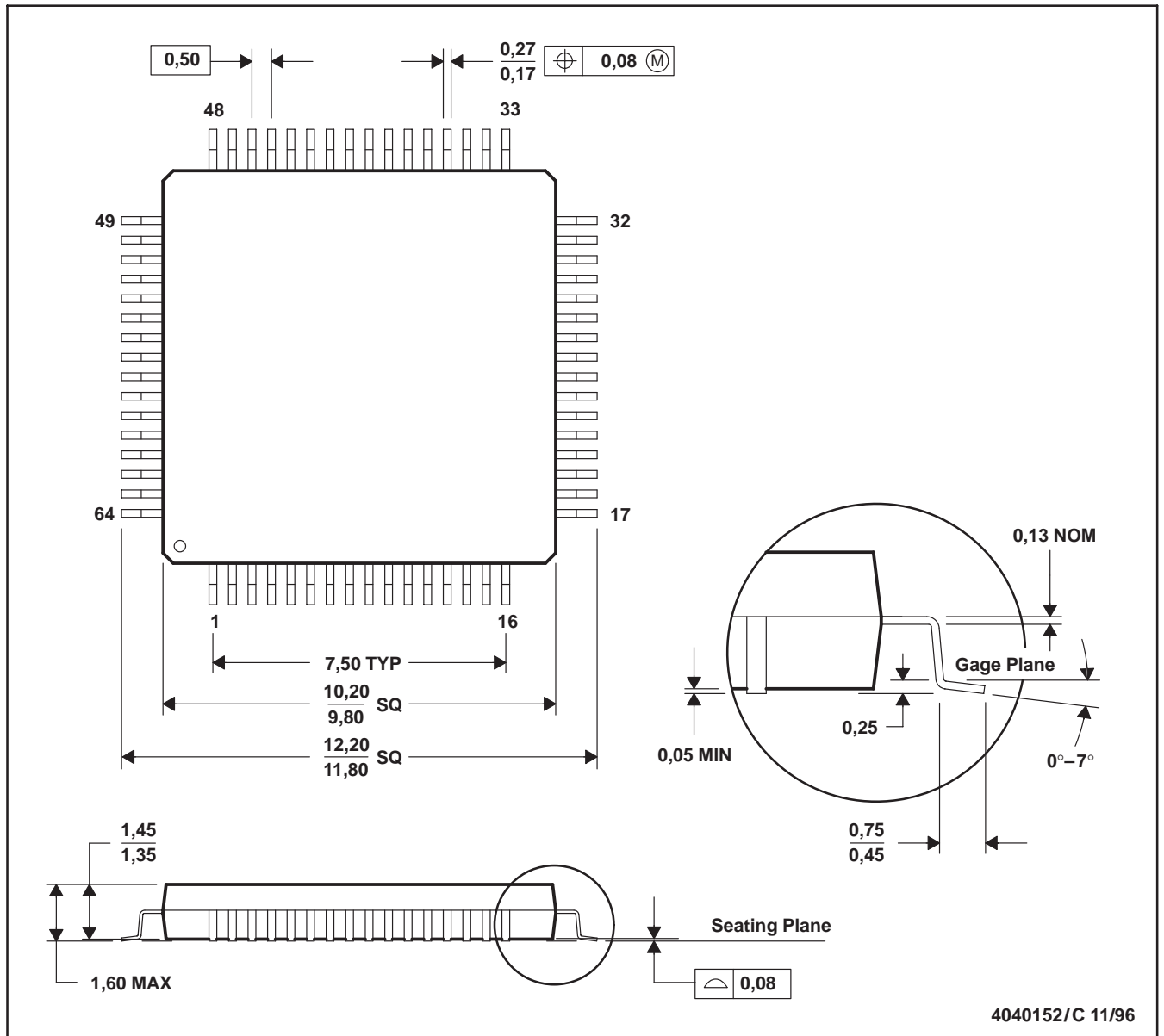
(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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PM (S-PQFP-G64)

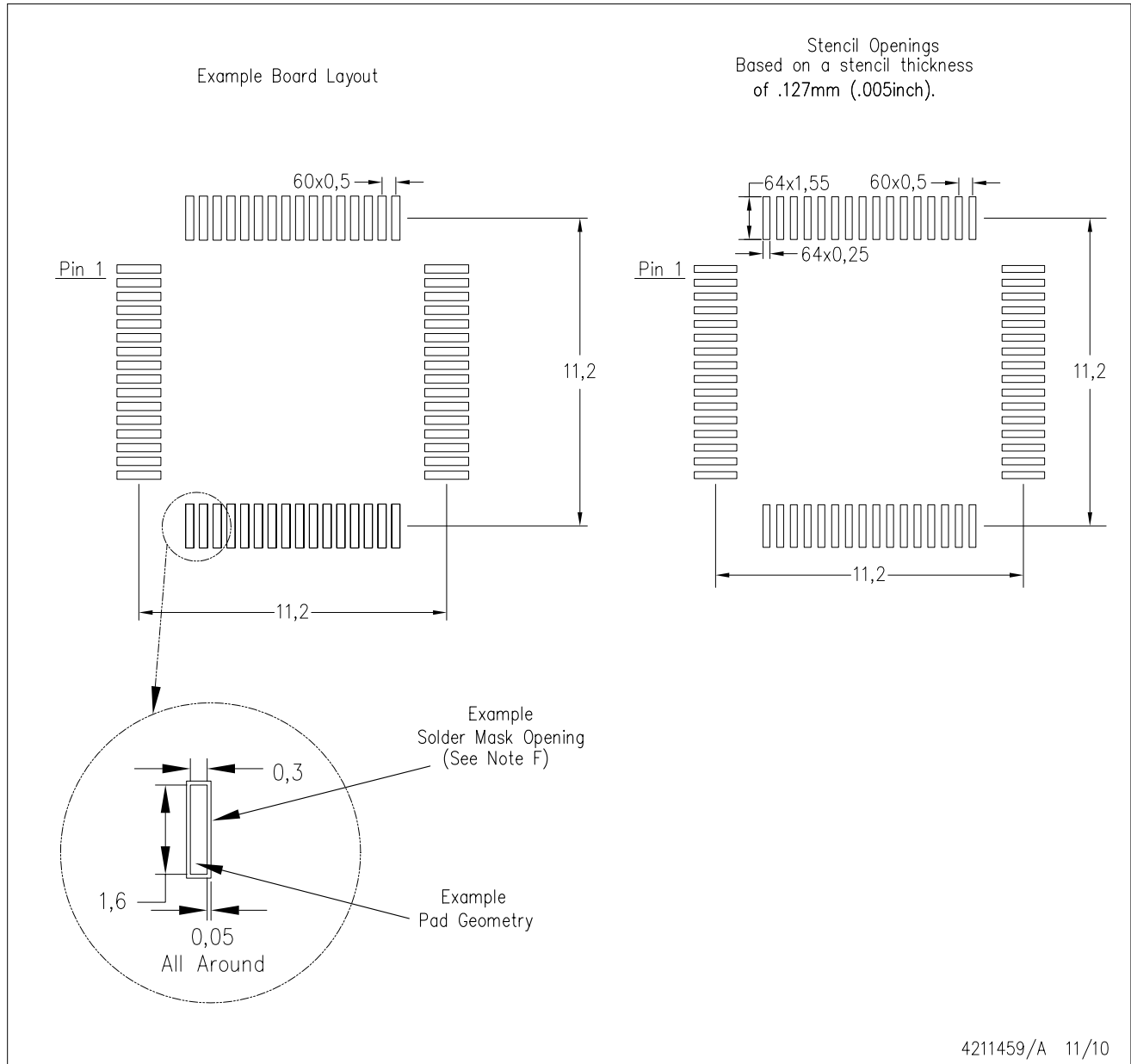
PLASTIC QUAD FLATPACK



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Falls within JEDEC MS-026
 D. May also be thermally enhanced plastic with leads connected to the die pads.

PM (S-PQFP-G64)

PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - D. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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